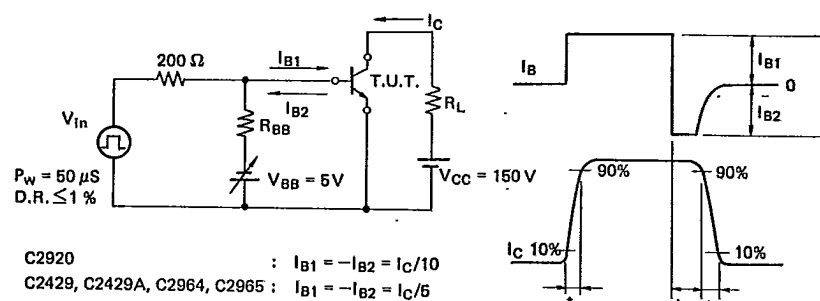
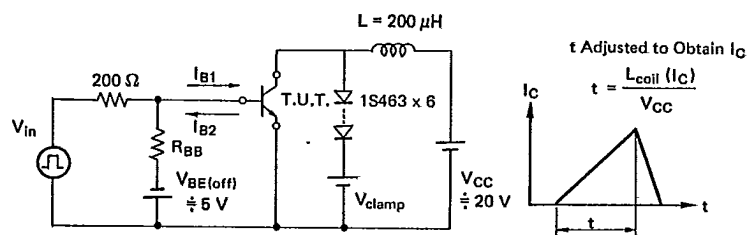


2SC2920, 2SC2429, 2SC2429A, 2SC2964, 2SC2965

● Test Circuit used for Measurement of Switching Time (Resistive)

● Test Circuit used for Measurement of $V_{CEX(SUS)}$ and Reverse Bias Safe Operating Area① $V_{CEX(SUS)}$

$$I_C = 8\text{ A}, I_{B1} = 2\text{ A}, I_{B2} = -1\text{ A}, R_{BB} = 5\ \Omega, V_{clamp} = 450\text{ V}$$

② Reverse Bias Safe Operating Area

$$I_{B1} \leq 4\text{ A}, I_{B2} = -1\text{ A}, R_{BB} = 5\ \Omega$$

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T-33-13

PRODUCT PROFILE

2SC2920

Silicon High Speed Power Transistor

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Rating	Symbol	2SC2920	Unit
Collector to Emitter Voltage	V_{CEO}	400	V
Collector to Base Voltage	V_{CBO}	450	V
Emitter to Base Voltage	V_{EBO}	7	V
Collector Current-Continuous	I_C	15	A
Collector Current-Pulsed ($P_w \leq 10 \text{ mS}$, D.R. $\leq 2\%$)	I_{CP}	20	A
Base Current-Continuous	I_B	5	A
Collector Power Dissipation ($T_C = 25^\circ\text{C}$)	P_C	150	W
Junction Temperature	T_J	175	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-65 \sim +175$	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Parameters	Symbols	Test Conditions	Limits			Unit
			Min.	Typ.	Max.	
Collector to Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = 100 \mu\text{A}$, $I_E = 0$	450	—	—	V
Emitter to Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E = 1 \text{ mA}$, $I_C = 0$	7	—	—	V
Collector to Emitter Sustaining Voltage	$V_{CEO(SUS)}$	$I_C = 1 \text{ A}$, $R_{BE} = \infty \Omega$	400	—	—	V
Collector to Emitter Sustaining Voltage	$V_{CEX(SUS)}$	$I_C = 8 \text{ A}$, $I_{B2} = -1 \text{ A}$, $L = 200 \mu\text{H}$ ^{(*)1}	450	—	—	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 450 \text{ V}$, $I_E = 0$	—	—	100	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 6 \text{ V}$, $I_C = 0$	—	—	100	μA
DC Current Gain	h_{FE}	$V_{CE} = 2 \text{ V}$, $I_C = 10 \text{ A}$ ^{(*)2}	10	13	30	—
Collector to Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10 \text{ A}$, $I_B = 1 \text{ A}$ ^{(*)2}	—	0.56	1.0	V
Base to Emitter Saturation Voltage	$V_{BE(sat)}$		—	1.2	1.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10 \text{ V}$, $I_E = 0$, $f = 1 \text{ MHz}$	—	240	—	PF
Gain Bandwidth Product	f_T	$V_{CE} = 10 \text{ V}$, $I_C = 2 \text{ A}$	—	30	—	MHz
Rise Time	t_r	$V_{CC} = 150 \text{ V}$ ^{(*)1} $I_C = 10 \text{ A}$, $I_{B1} = -I_{B2} = 1 \text{ A}$	—	0.20	0.5	μs
Storage Time	t_{stg}		—	1.80	3.0	μs
Fall Time	t_f		—	0.18	0.3	μs

*1 Test Circuit

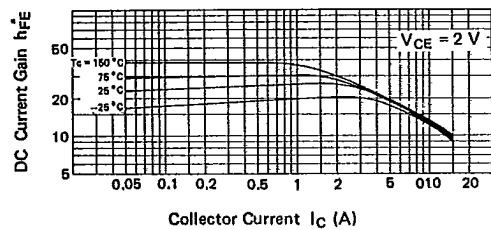
*2 Pulsed $P_w \leq 300 \mu\text{s}$, Duty Ratio $\leq 6\%$

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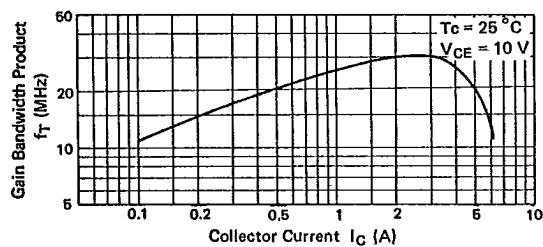
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2SC2920

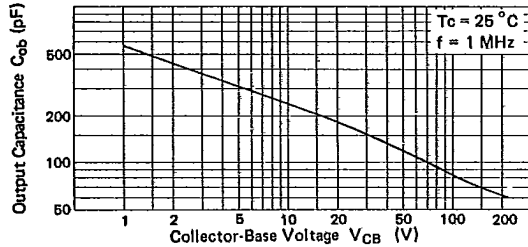
DC Current Gain



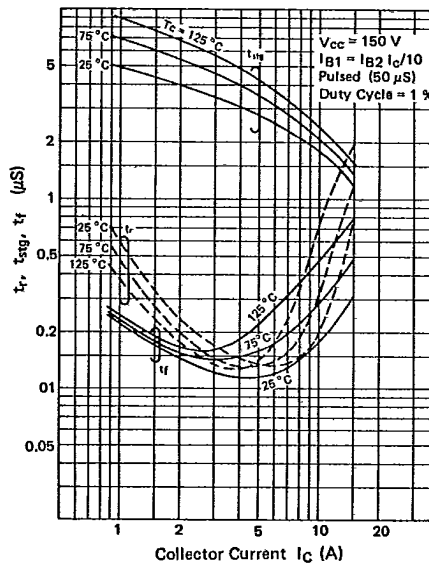
Gain Bandwidth Product



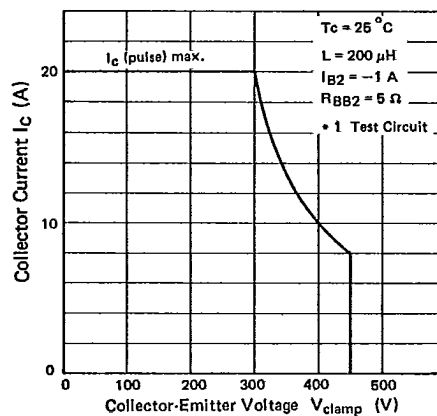
Output Capacitance



Switching Time



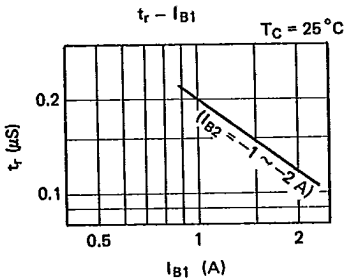
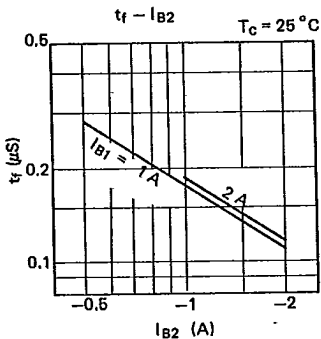
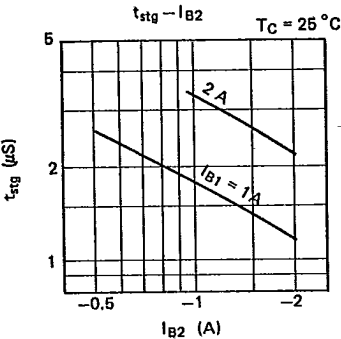
Reverse Bias Safe Operating Area



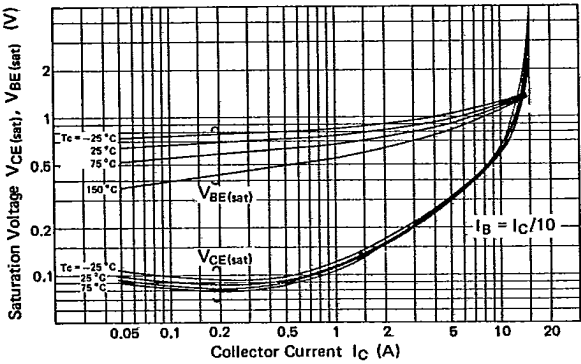
2SC2920

Switching Time

$V_{CC} = 150\text{ V}$
 $I_C = 10\text{ A}$
Pulsed ($50\text{ }\mu\text{S}$)
Duty Ratio = 1 %

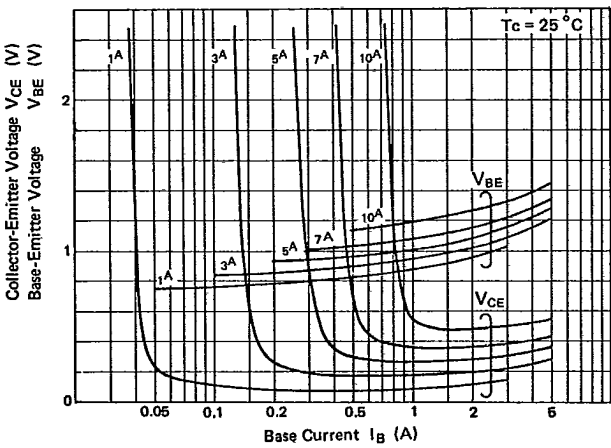


Saturation Voltage



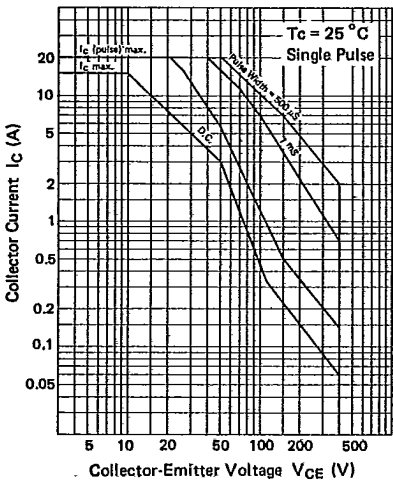
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Collector Saturation Region

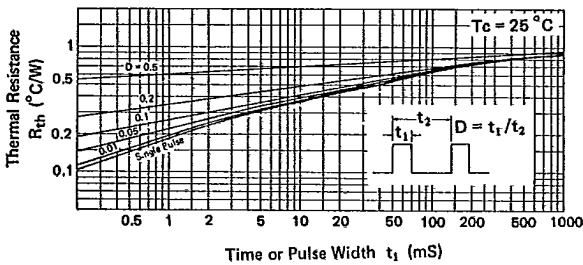


2SC2920

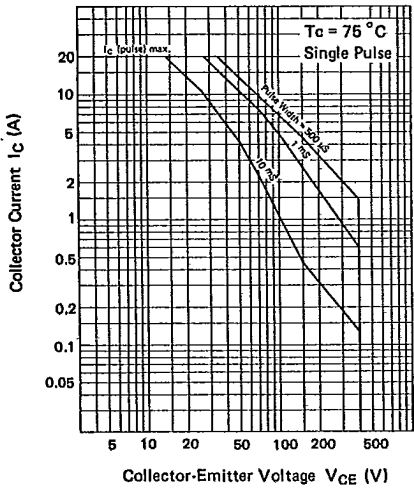
Forward Bias Safe Operating Area



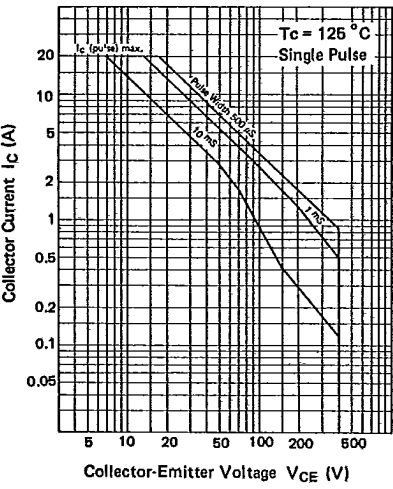
Thermal Response



Forward Bias Safe Operating Area



Forward Bias Safe Operating Area



2SC2429, 2SC2429A

Silicon High Speed Power Transistor

ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C)

Rating	Symbol	2SC2429	2SC2429A	Unit
Collector to Emitter Voltage	V _{CEO}	400	450	V
Collector to Base Voltage	V _{CBO}	450	600	V
Emitter to Base Voltage	V _{EBO}	7	7	V
Collector Current-Continuous	I _C	15	15	A
Collector Current-Pulsed ($P_w \leq 10 \text{ mS}$, $D.R. \leq 2 \%$)	I _{CP}	20	20	A
Base Current-Continuous	I _B	5	5	A
Collector Power Dissipation (T _C = 25°)	P _C	150	150	W
Junction Temperature	T _J	175	175	°C
Storage Temperature Range	T _{stg}	-65 ~ +175	-65 ~ +175	°C



ELECTRICAL CHARACTERISTICS (Ta = 25 °C)

Parameters	Symbols	Test Conditions	Limits			Unit	
			Min.	Typ.	Max.		
Collector to Base Breakdown Voltage	V _{(BR)CBO}	2SC2429: I _C = 100 μA, I _E = 0	450	—	—	V	
		2SC2429A: I _C = 1 mA, I _E = 0	600	—	—	V	
Emitter to Base Breakdown Voltage	V _{(BR)EBO}	I _E = 1 mA, I _C = 0	7	—	—	V	
Collector Emitter Sustaining Voltage	V _{CEO(SUS)}	2SC2429 I _C = 1 A, R _{BE} = ∞Ω	400	—	—	V	
		2SC2429A	450	—	—	V	
Collector to Emitter Sustaining Voltage	V _{CEX(SUS)}	I _C = 8 A, I _{B2} = -1 A, L = 200 μH (*1)	450	—	—	V	
Collector Cutoff Current	I _{CBO}	2SC2429: V _{CB} = 450 V, I _E = 0	—	—	100	μA	
		2SC2429A: V _{CB} = 500 V, I _E = 0	—	—	100	μA	
Emitter Cutoff Current	I _{EBO}	V _{EB} = 6 V, I _C = 0	—	—	100	μA	
DC Current Gain	h _{FE}	V _{CE} = 5 V, I _C = 10 A (*2)	10	15	40	—	
Collector to Emitter Saturation Voltage	V _{CE(sat)}	I _C = 10 A, I _B = 2 A (*2)	—	0.56	1.0	V	
Base to Emitter Saturation Voltage	V _{BE(sat)}		2SC2429	—	1.25	2.0	V
			2SC2429A	—	1.25	1.5	V
Output Capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	—	240	—	PF	
Gain Bandwidth Product	f _T	V _{CE} = 10 V, I _C = 2 A	—	30	—	MHz	
Rise Time	t _r	V _{CC} = 150 V I _C = 10 A, I _{B1} = -I _{B2} = 2 A (*1)	—	0.13	0.5	μs	
Storage Time	t _{stg}		—	1.80	2.5	μs	
Fall Time	t _f		—	0.11	0.3	μs	

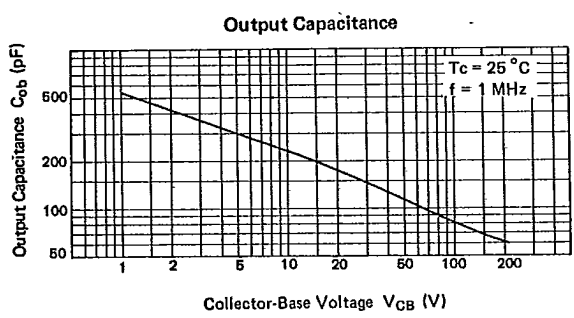
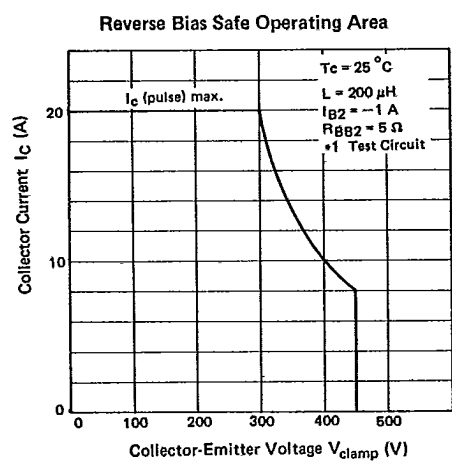
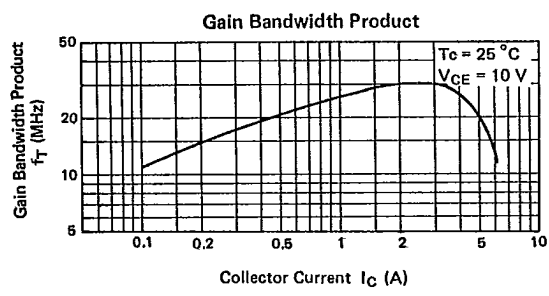
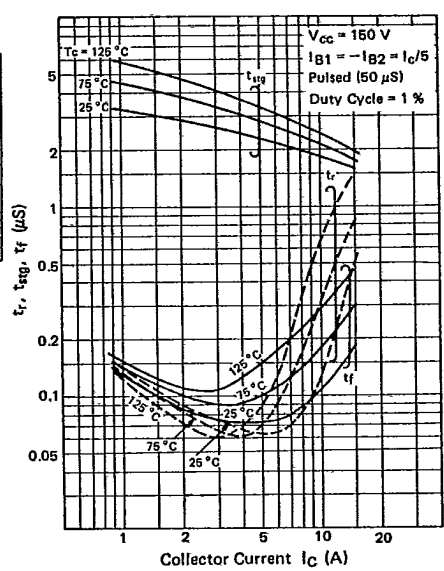
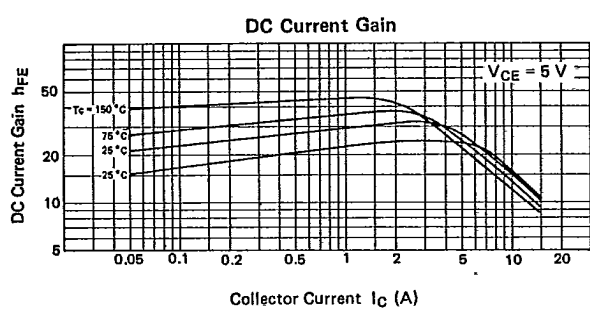
*1 Test Circuit

*2 Pulsed P_w ≤ 300 μs, Duty Ratio ≤ 6 %

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2SC2429, 2SC2429A

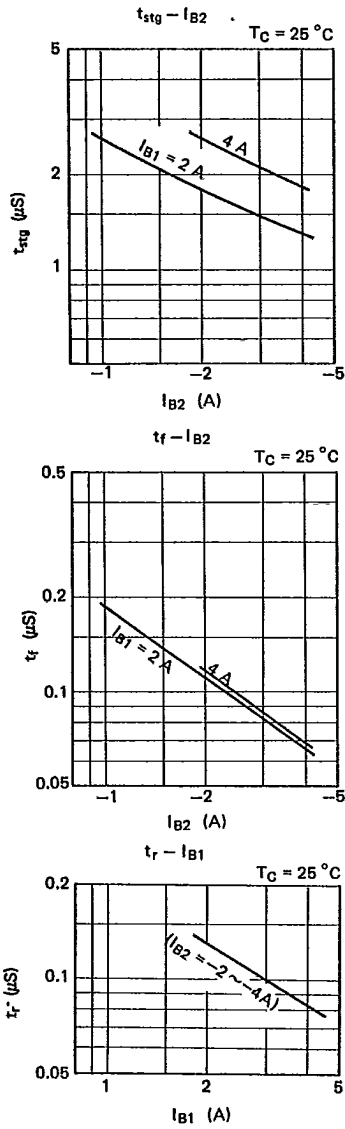
Switching Time



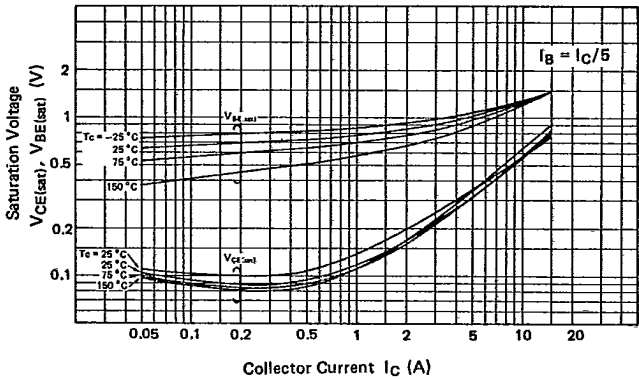
2SC2429, 2SC2429A

Switching Time

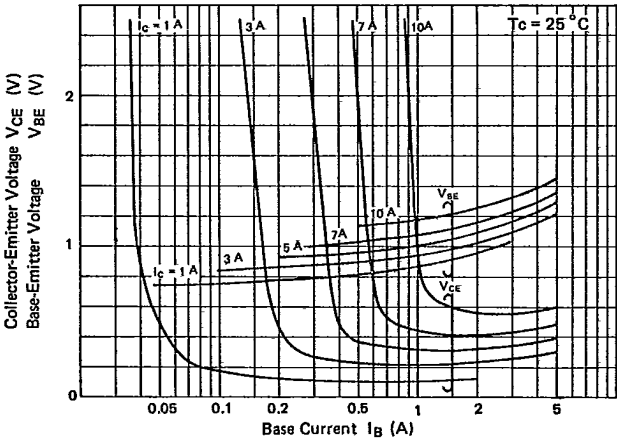
$V_{CC} = 150\text{ V}$
 $I_C = 10\text{ A}$
Pulsed (50 μs)
Duty Ratio = 1 %



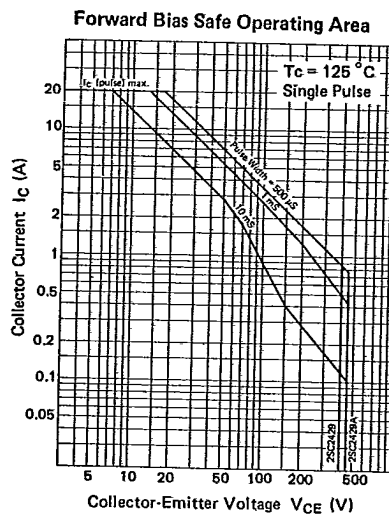
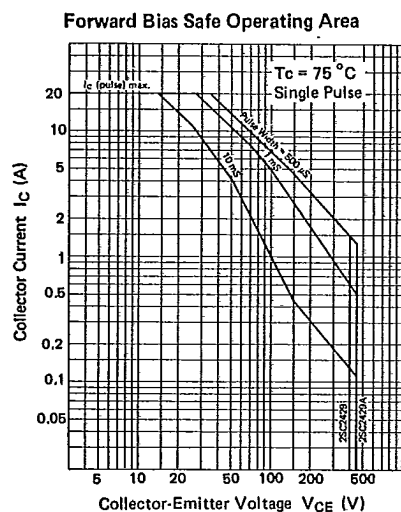
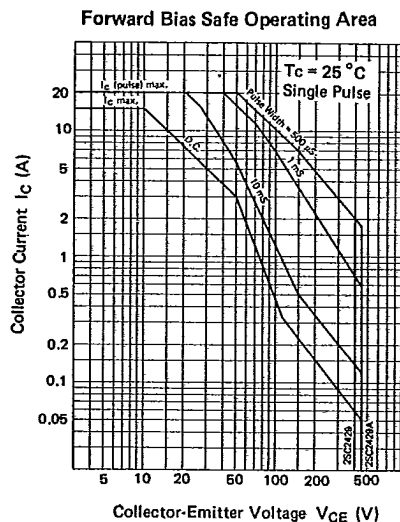
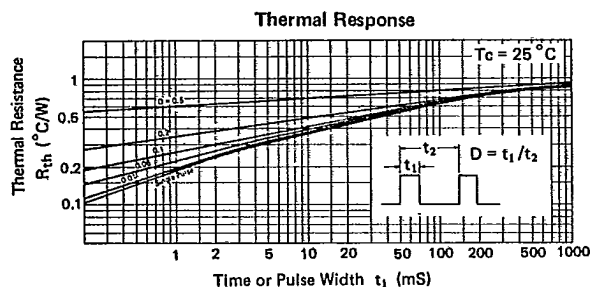
Saturation Voltage



Collector Saturation Region



2SC2429, 2SC2429A



January 1990
Edition 1.1

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PRODUCT PROFILE

2SC2964, 2SC2965**Silicon High Speed Power Transistor**ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Rating	Symbol	2SC2964	2SC2965	Unit
Collector to Emitter Voltage	V_{CE0}	400	450	V
Collector Base Voltage	V_{CBO}	600	600	V
Emitter to Base Voltage	V_{EBO}	7	7	V
Collector Current-Continuous	I_C	15	15	A
Collector Current-Pulsed ($P_w \leq 10 \text{ mS}$, $D.R. \leq 2\%$)	I_{CP}	20	20	A
Base Current-Continuous	I_B	5	5	A
Collector Power Dissipation ($T_C = 25^\circ\text{C}$)	P_C	150	150	W
Junction Temperature	T_j	175	175	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-65 \sim +175$	$-65 \sim +175$	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Parameters	Symbols	Test Conditions	Limits			Unit
			Min.	Typ.	Max.	
Collector to Base Breakdown Voltage	$V_{(BR)CBO}$	$I_C = 1 \text{ mA}$, $I_E = 0$	600	—	—	V
Emitter to Base Breakdown Voltage	$V_{(BR)EBO}$	$I_E = 1 \text{ mA}$, $I_C = 0$	7	—	—	V
Collector to Emitter Sustaining Voltage	$V_{CE0(SUS)}$	$I_C = 0.8 \text{ A}$, $R_{BE} = \infty \Omega$	2SC2964	400	—	V
			2SC2965	450	—	V
Collector to Emitter Sustaining Voltage	$V_{CEX(SUS)}$	$I_C = 8 \text{ A}$, $I_{B2} = -1 \text{ A}$, $L = 200 \mu\text{H}$ (*)	450	—	—	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 500 \text{ V}$, $I_E = 0$	—	—	100	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 6 \text{ V}$, $I_C = 0$	—	—	100	μA
DC Current Gain	h_{FE}	$V_{CE} = 5 \text{ V}$, $I_C = 10 \text{ A}$ (*)	7	8.5	20	—
Collector to Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10 \text{ A}$, $I_B = 2 \text{ A}$ (*)	—	0.75	1.5	V
Base to Emitter Saturation Voltage	$V_{BE(sat)}$		—	1.25	1.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10 \text{ V}$, $I_E = 0$, $f = 1 \text{ MHz}$	—	230	—	pF
Gain Bandwidth Product	f_T	$V_{CE} = 10 \text{ V}$, $I_C = 2 \text{ A}$	—	28	—	MHz
Rise Time	t_r	$V_{CC} = 150 \text{ V}$ $I_C = 10 \text{ A}$, $I_{B1} = -I_{B2} = 2 \text{ A}$ (*)	—	0.15	0.5	μs
Storage Time	t_{stg}		—	0.84	1.0	μs
Fall Time	t_f		—	0.10	0.3	μs

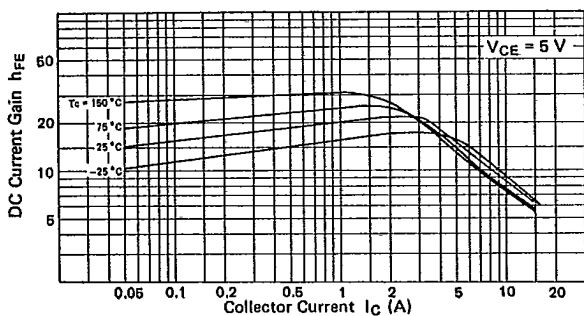
*1 Test Circuit

*2 Pulsed $P_w \leq 300 \mu\text{s}$, Duty Ratio $\leq 6\%$

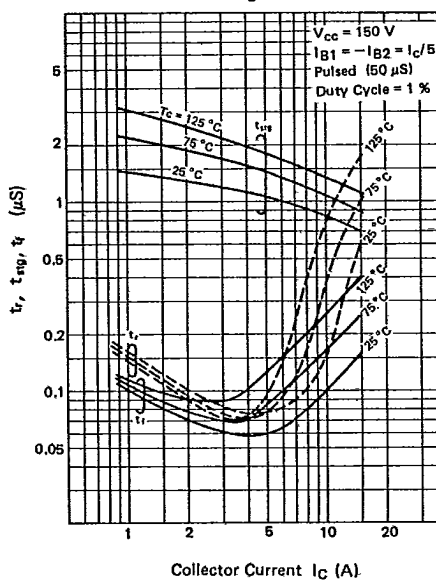
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2SC2964, 2SC2965

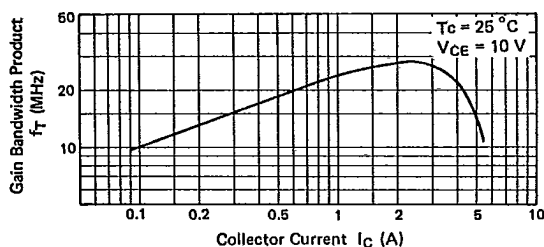
DC Current Gain



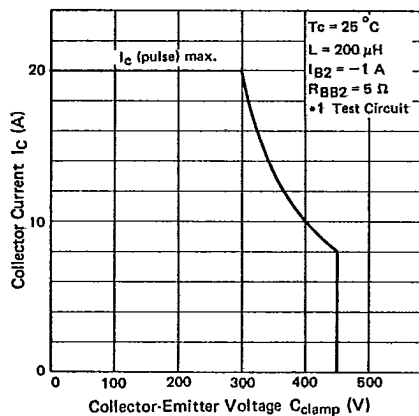
Switching Time



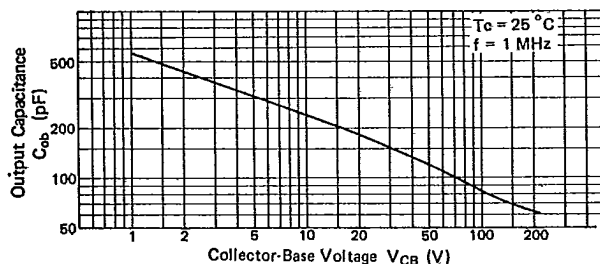
Gain Bandwidth Product



Reverse Bias Safe Operating Area



Output Capacitance

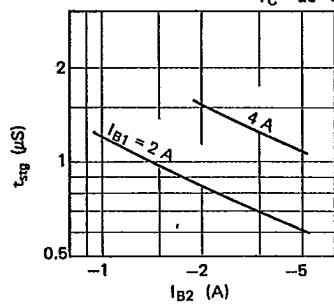
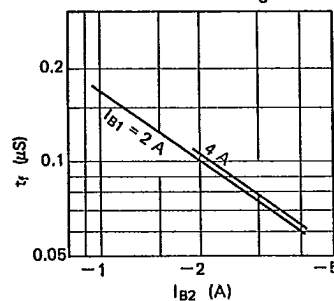
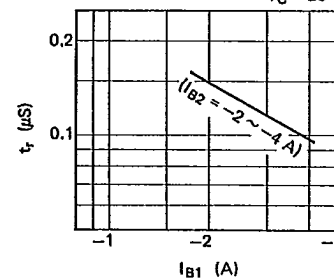


2SC2964, 2SC2965

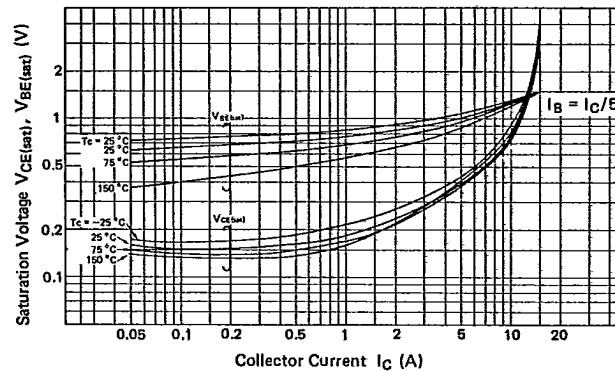
Switching Time

 $V_{CC} = 150 \text{ V}$ $I_C = 10 \text{ A}$ Pulsed ($50 \mu\text{s}$)

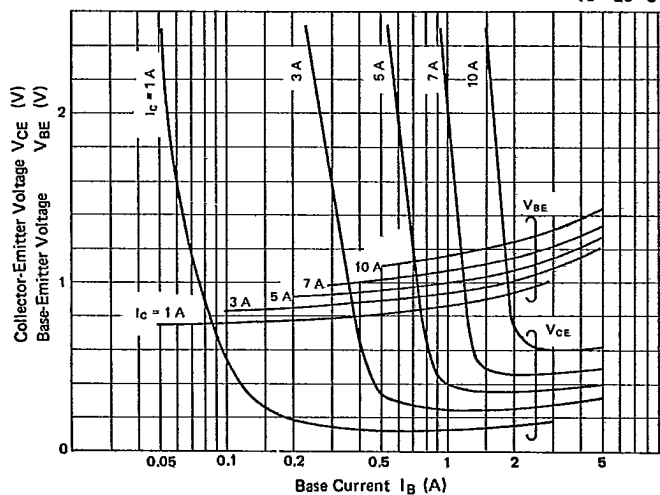
Duty Ratio = 1 %

 $t_{stg} - I_{B2}$
 $T_C = 25^\circ\text{C}$  $t_f - I_{B2}$
 $T_C = 25^\circ\text{C}$  $t_r - I_{B1}$
 $T_C = 25^\circ\text{C}$ 

Saturation Voltage



Collector Saturation Region

 $T_C = 25^\circ\text{C}$ 

2SC2964, 2SC2965

